

● General Description

It combines trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

● Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

● Application

- BLDC Motor driver
- DC-DC
- Load Switch

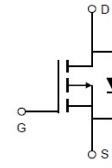
● Ordering Information:

Part NO.	ZMA950P04T1
Marking	950P04
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

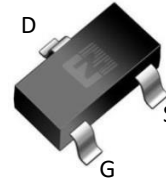
● Absolute Maximum Ratings ( $T_A=25^{\circ}\text{C}$ , unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-Source Voltage	$V_{DS}$		-	-40	V
Gate-Source Voltage	$V_{GS}$		-20	20	V
Continuous Drain Current	$I_D$	$V_{GS}=-10\text{V}, T_A=25^{\circ}\text{C}$	-	-1.8	A
	$I_D$	$V_{GS}=-10\text{V}, T_A=75^{\circ}\text{C}$	-	-1.4	A
	$I_D$	$V_{GS}=-10\text{V}, T_A=100^{\circ}\text{C}$	-	-1.1	A
Pulsed Drain Current	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}; T_A = 25^{\circ}\text{C};$	-	-7.2	A
Total Power Dissipation	$P_D$	$T_A=25^{\circ}\text{C} (t \leq 10\text{s})$	-	0.6	W
Total Power Dissipation	$P_D$	$T_A=25^{\circ}\text{C}$ (Steady-state)	-	0.4	W
Operating Junction Temperature	$T_J$		-55	150	$^{\circ}\text{C}$
Storage Temperature	$T_{STG}$		-55	150	$^{\circ}\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}, V_{GS}=-10\text{V}, R_g=25\Omega,$	-	7.2	mJ
		$L=0.5\text{mH}, V_{GS}=-10\text{V}, R_g=25\Omega,$	-	13.0	mJ
ESD Level (HBM)	CLASS 1B				

● Product Summary



$V_{DS} = -40\text{V}$   
 $R_{DS(ON)} = 96\text{m}\Omega$   
 $I_D = -1.8\text{A}$



SOT-23-3



**●Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction-ambient <sup>①</sup>	$R_{thJA}(t \leq 10s)$	-	-	220	°C/W
Thermal resistance, junction-ambient <sup>①</sup>	$R_{thJA}(\text{Steady-state})$	-	-	300	°C/W
Soldering temperature	Tsold	-	-	260	°C

**●Electronic Characteristics (T<sub>j</sub>=25°C, unless otherwise specified)**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-40	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu A, T_j = 25^\circ C$	-1.3	-2	-2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS} = 0V, V_{DS} = -40V, T_j = 25^\circ C$	-	-	1.0	$\mu A$
		$V_{GS} = 0V, V_{DS} = -40V, T_j = 150^\circ C$	-	-	100	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -1.5A, T_j = 25^\circ C$	-	96	115	m $\Omega$
		$V_{GS} = -10V, I_D = -1.5A, T_j = 150^\circ C$	-	154	-	m $\Omega$
		$V_{GS} = -4.5V, I_D = -1A, T_j = 25^\circ C$	-	152	200	m $\Omega$
		$V_{GS} = -4.5V, I_D = -1A, T_j = 150^\circ C$	-	228	-	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = -5V, I_D = -1.5A$	-	2.7	-	S
Diode Forward Voltage	$V_{FSD}$	$V_{GS} = 0V, I_{SD} = -1.5A$	-	-	-1.3	V

**●Dynamic characteristics (T<sub>j</sub>=25°C, unless otherwise specified)**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	
Input capacitance	$C_{iss}$	$f = 1MHz, V_{DS} = -20V, V_{GS} = 0V$	-	391	-	pF	
Output capacitance	$C_{oss}$		-	33	-		
Reverse transfer capacitance	$C_{rss}$		-	22	-		
Gate Resistance	$R_g$	$f = 1MHz, V_{GS} = 0V$	-	17	-	$\Omega$	
Total gate charge	$Q_g$	$V_{DD} = -20V, I_D = -1.5A, V_{GS} = -10V$	-	6.8	-	nC	
	$Q_g(-4.5V)$		-	3.2	-		
	Gate - Source charge		$Q_{gs}$	-	1.9		-
	Gate - Drain charge		$Q_{gd}$	-	0.8		-
Turn-ON Delay time	$t_{D(on)}$	$V_{GS} = -10V, V_{DS} = -20V, R_G = 3.3\Omega, I_D = -1.5A$	-	3.2	-	ns	
Turn-ON Rise time	$t_r$		-	18.7	-	ns	
Turn-Off Delay time	$t_{D(off)}$		-	16.9	-	ns	
Turn-Off Fall time	$t_f$		-	22.5	-	ns	
Reverse Recovery Time	$t_{rr}$	$V_{DD} = -20V, di_S/dt = 100A/\mu s, I_S = -1.5A$	-	11	-	ns	
Reverse Recovery Charge	$Q_{rr}$		-	6	-	nC	

Fig.1 Gate-source voltage as a function of gate charge; Typical values;  $T_j=25^\circ\text{C}$

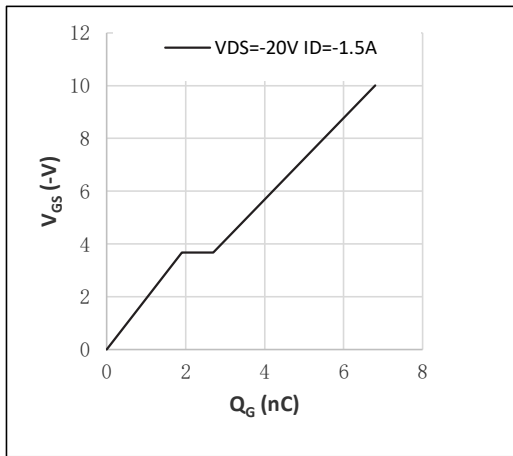


Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values;  $T_j=25^\circ\text{C}$

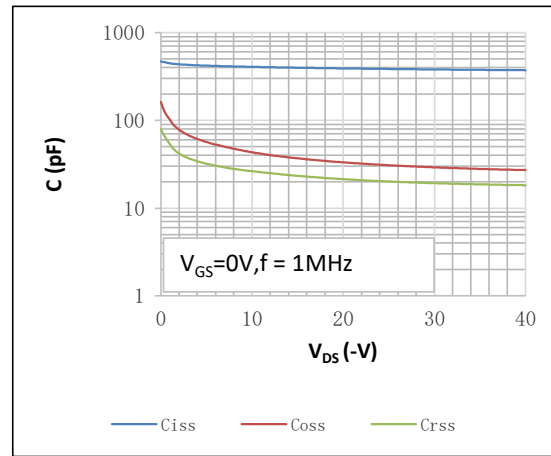


Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values;  $T_j=25^\circ\text{C}$

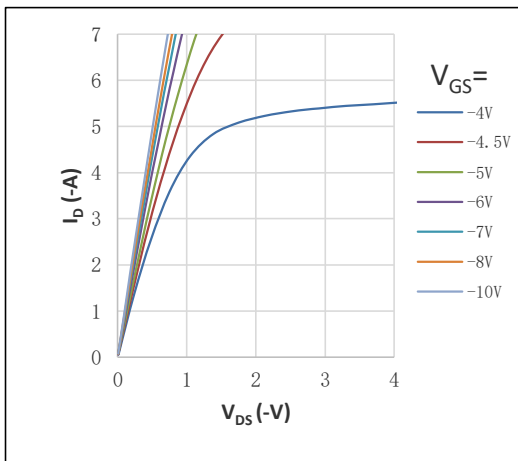


Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values; Expanded curve;  $T_j=25^\circ\text{C}$

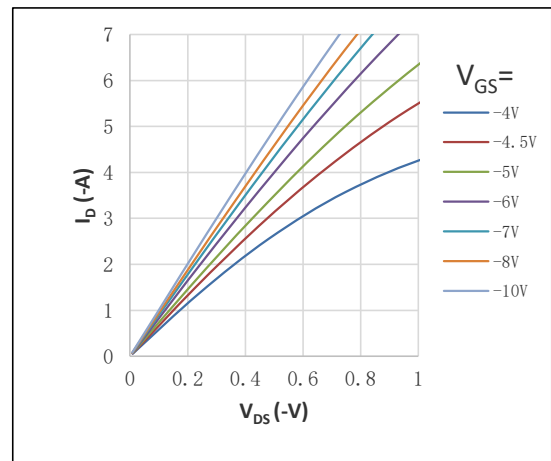


Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values

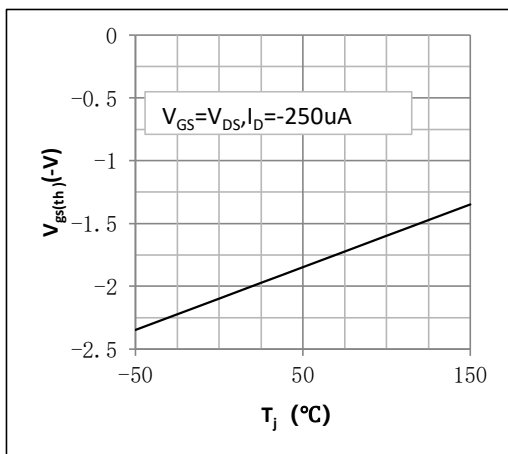


Fig.6 Drain-source on-state resistance as a function of drain current; Typical values;  $T_j=25^\circ\text{C}$

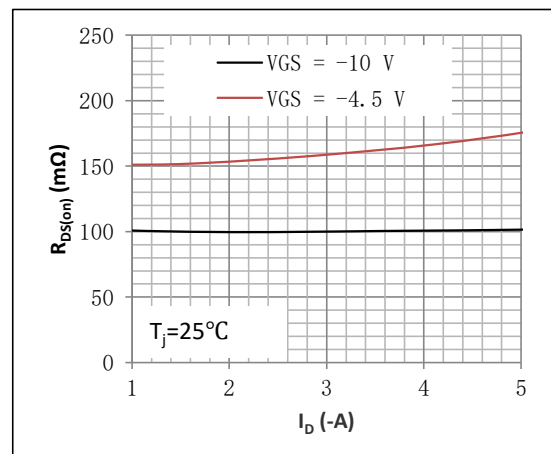


Fig.7 Drain-source on-state resistance as a function of gate-source voltage;Typical values

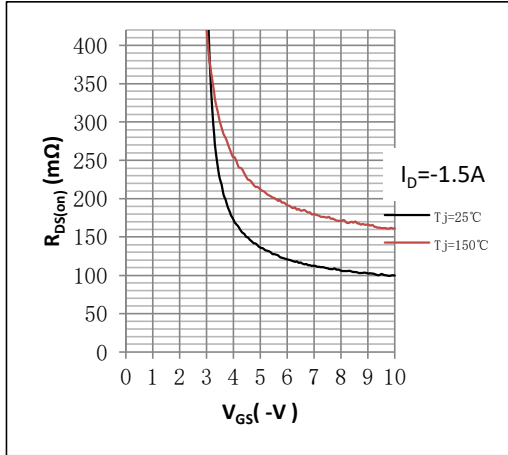


Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature;Typical values  
Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^\circ\text{C})$

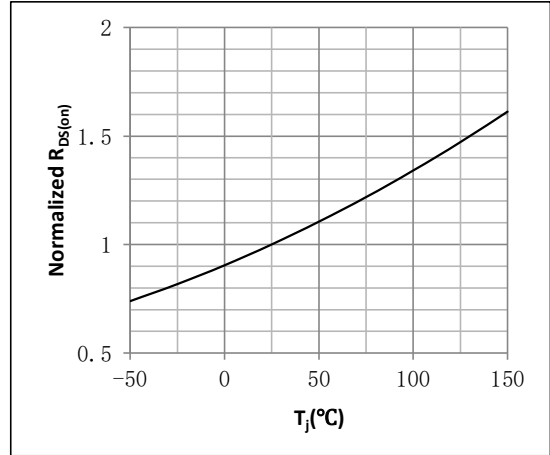


Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage ;Typical values

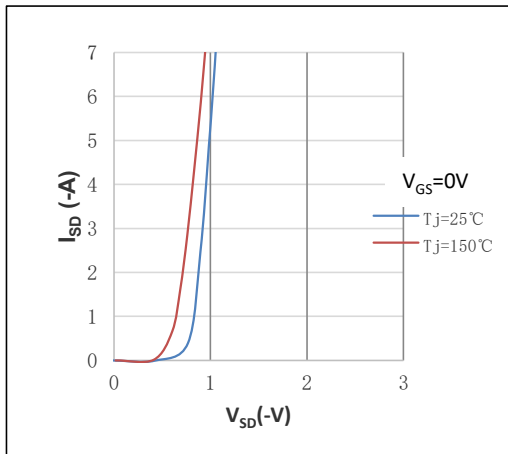


Figure 10. Transfer characteristics: drain current as a function of gate-source voltage;Typical values

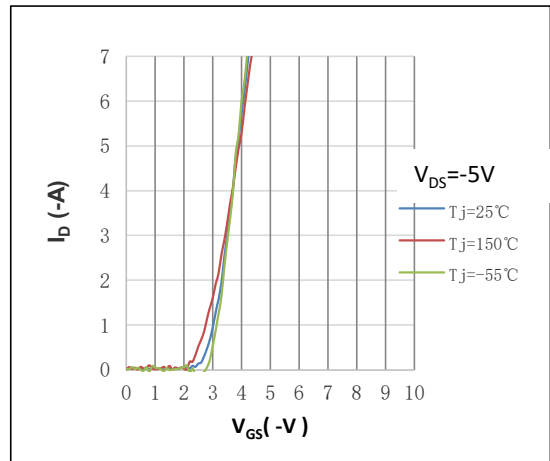


Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage;Calculative values

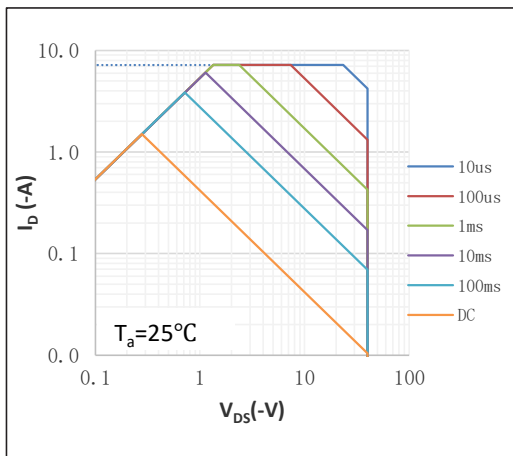


Fig.12 Continuous drain current as a function of ambient temperature<sup>Ⓢ</sup>;Calculative values

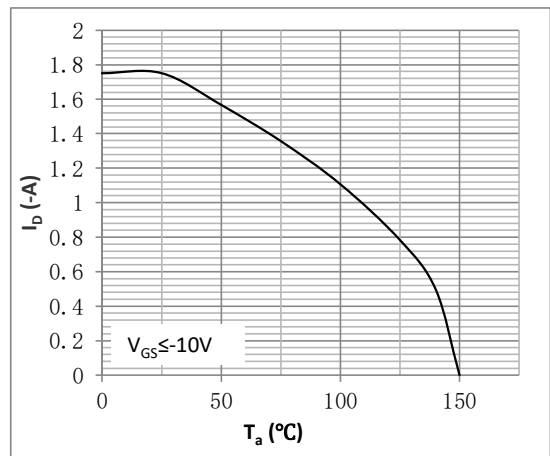


Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values  
Normalized BVDSS=BVDSS/BVDSS(25°C)

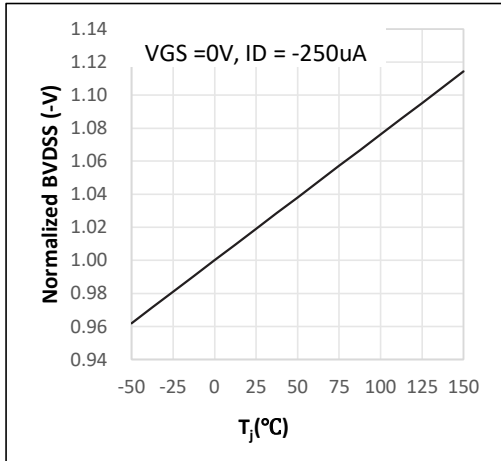


Fig.14 Normalized total power dissipation as a function of ambient temperature; Calculative values  
Normalized Power Dissipation= $P_d/P_d(25^\circ\text{C})$

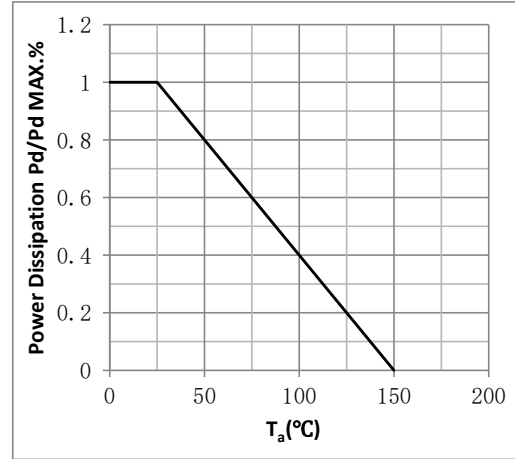
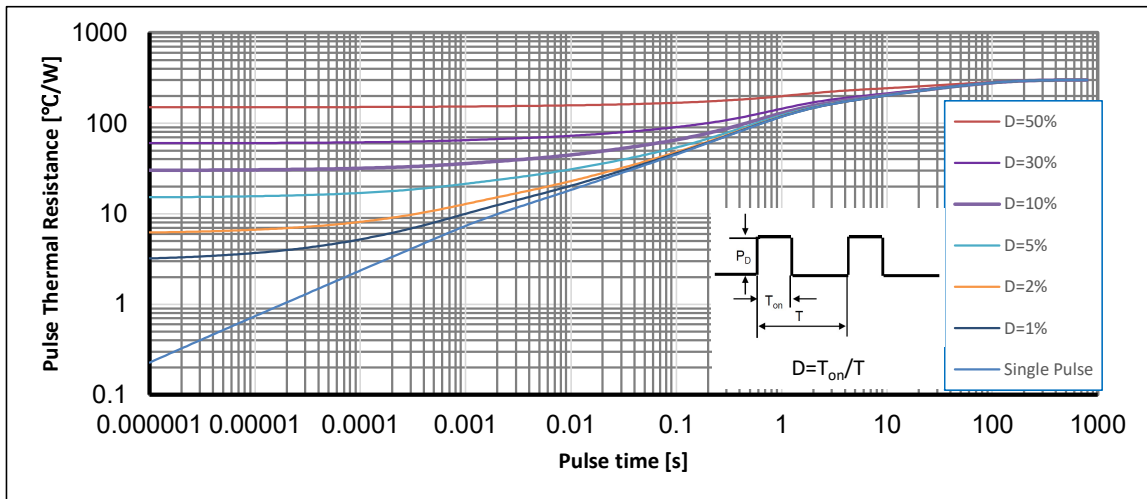
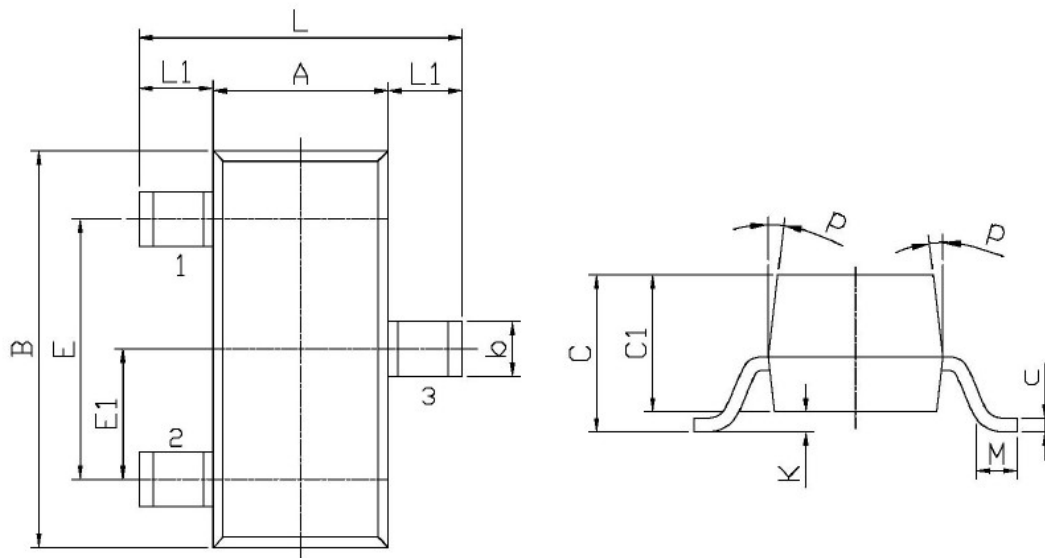


Fig.15 Transient thermal impedance from junction to ambient as a function of pulse duration; max values



•SOT-23-3 Package Outline



Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
L	2.2	2.7	C	1.30Max	
L1	0.45	0.65	C1	0.90	1.20
A	1.15	1.50	c	0.05	0.20
B	2.70	3.10	K	0	0.10
E	1.70	2.10	M	0.20MIN	
E1	0.85	1.05	P	7°	
b	0.35	0.55			

**Note:**

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. VGS=-10V.

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Revision History

Version	Date	Change
Preliminary	2025/2/9	NEW